Amendments to the Claims

The listing of claims will replace all prior versions, and listings of claims in the application.

1. (currently amended) An integrated packet bit error rate tester, comprising: a substrate;

a packet transmit circuit including a first memory for storing transmit bit error rate test packet data, wherein the packet transmit circuit is coupled to a channel under test;

a packet receive circuit including a second memory for storing received packet compare data and coupled to the channel under test;

an interface for programming the packet transmit circuit and the packet receive circuit;

wherein said packet transmit circuit and said packet receive circuit are deposited on said substrate;

wherein the packet transmit circuit generates an arbitrary packet pattern in response to a command from the interface; and

wherein the packet receive circuit determines a bit error rate of the channel under test.

2. (original) The integrated packet bit error rate tester of claim 1, wherein the packet transmit circuit includes a first pseudo-random number generator for generating the arbitrary packet pattern.

- 3. (original) The integrated packet bit error rate tester of claim 2, wherein the packet receive circuit includes a second pseudo-random number generator for generating the same arbitrary packet pattern that is generated by the first pseudo-random number generator.
- 4. (previously presented) The integrated packet bit error rate tester of claim 1, wherein the packet transmit circuit includes a byte counter for counting a number of bytes transmitted during bit error rate testing.
- 5. (previously presented) The integrated packet bit error rate tester of claim 1, wherein the packet transmit circuit includes a packet counter for counting a number of packets transmitted during bit error rate testing.
- 6. (original) The integrated packet bit error rate tester of claim 1, wherein the packet receive circuit includes a bit error counter for counting a number of bit errors detected during bit error rate testing.
- 7. (original) The integrated packet bit error rate tester of claim 1, wherein the packet receive circuit includes a byte error counter for counting a number of bytes with at least one bit in error detected during bit error rate testing.

- 8. *(original)* The integrated packet bit error rate tester of claim 1, wherein the packet receive circuit includes a packet error counter for counting a number of packets with at least one byte in error detected during bit error rate testing.
- 9. (previously presented) The integrated packet bit error rate tester of claim 1, wherein the second memory captures the received packet compare data only after a pre-programmed pattern is detected.
- 10. (original) The integrated packet bit error rate tester of claim 9, wherein the pre-programmed pattern includes a fixed pattern.
- 11. *(original)* The integrated packet bit error rate tester of claim 9, wherein the pre-programmed pattern includes a programmable pattern.
- 12. (previously presented) The integrated packet bit error rate tester of claim 9, wherein the pre-programmed pattern includes a cyclic redundancy check pattern.
- 13. *(previously presented)* The integrated packet bit error rate tester of claim 1, wherein the arbitrary packet pattern is received from an external random access memory.

- 14. *(previously presented)* The integrated packet bit error rate tester of claim 1, wherein the arbitrary packet pattern can be loaded into a random access memory for bit error rate testing.
- 15. (previously presented) The integrated packet bit error rate tester of claim 1, wherein the second memory captures the received packet compare data only after a pre-programmed pattern is lost.
- 16. (previously presented) The integrated packet bit error rate tester of claim 1, wherein the second memory captures the received packet compare data only after an error is detected.
- 17. *(previously presented)* The integrated packet bit error rate tester of claim 1, wherein the second memory captures the received packet compare data continuously.
- 18. *(previously presented)* The integrated packet bit error rate tester of claim 1, further including a finite state machine for controlling capture of the received packet compare data.
- 19. (original) The integrated packet bit error rate tester of claim 1, wherein the packet receive circuit includes a byte counter for counting a total number of bytes received.

- 20. (original) The integrated packet bit error rate tester of claim 1, wherein the packet receive circuit includes a packet counter for counting a total number of packets received.
- 21. (original) The integrated packet bit error rate tester of claim 1, wherein the packet transmit circuit includes a byte counter for counting a total number of bytes transmitted.
- 22. (original) The integrated packet bit error rate tester of claim 1, wherein the packet transmit circuit includes a packet counter for counting a total number of packets transmitted.
- 23. (previously presented) The integrated packet bit error rate tester of claim 1, wherein the arbitrary packet pattern is a ten gigahertz serializer / deserializer packet.
 - 24. *(currently amended)* An integrated packet bit error rate tester, comprising: a substrate;

a packet transmit circuit including a first memory for storing transmit bit error rate test packet data, wherein the packet transmit circuit is coupled to a channel under test;

a packet receive circuit including a second memory for capturing received packet compare data from the channel under test;

an interface for programming the packet transmit circuit and the packet receive circuit;

wherein said packet transmit circuit and said packet receive circuit are deposited on said substrate;

wherein the packet transmit circuit generates an arbitrary serializer / deserializer (SERDES) packet pattern in response to a command from the interface; and

wherein the packet receive circuit determines a bit error rate of the channel under test based on the transmit packet data compared to the receive packet data.

- 25. (original) The integrated packet bit error rate tester of claim 24, wherein the packet receive circuit includes a byte counter for counting a total number of bytes received.
- 26. (original) The integrated packet bit error rate tester of claim 24, wherein the packet receive circuit includes a packet counter for counting a total number of packets received.
- 27. (original) The integrated packet bit error rate tester of claim 24, wherein the packet transmit circuit includes a byte counter for counting a total number of bytes transmitted.

- 28. (original) The integrated packet bit error rate tester of claim 24, wherein the packet transmit circuit includes a packet counter for counting a total number of packets transmitted.
- 29. (original) The integrated packet bit error rate tester of claim 24, wherein the packet transmit circuit includes a first pseudo-random number generator for generating the arbitrary SERDES packet pattern.
- 30. (original) The integrated packet bit error rate tester of claim 29, wherein the packet receive circuit includes a second pseudo-random number generator for generating the same arbitrary SERDES packet pattern that is generated by the first pseudo-random number generator.
- 31. *(original)* The integrated packet bit error rate tester of claim 29, wherein the second memory captures the received packet data only after a pre-programmed pattern is detected.
- 32. *(original)* The integrated packet bit error rate tester of claim 31, wherein the pre-programmed pattern includes a fixed pattern.
- 33. *(original)* The integrated packet bit error rate tester of claim 31, wherein the pre-programmed pattern includes a programmable pattern.

- 34. *(previously presented)* The integrated packet bit error rate tester of claim 31, wherein the pre-programmed pattern includes a cyclic redundancy check pattern.
- 35. (original) The integrated packet bit error rate tester of claim 24, wherein the second memory captures the received packet data only after a pre-programmed pattern is lost.
- 36. *(original)* The integrated packet bit error rate tester of claim 24, wherein the second memory captures the received packet data only after an error is detected.
- 37. *(previously presented)* The integrated packet bit error rate tester of claim 24, wherein the second memory captures the received packet data continuously.
 - 38-40. (canceled).
- 41. *(currently amended)* A method of testing a bit error rate of a channel coupled to a transmitter memory deposited on a substrate and to a receiver deposited on the substrate, comprising:

generating a test packet including an arbitrary marker pattern;
loading the test packet into the transmitter memory;
transmitting the test packet from the transmitter memory over the channel;
capturing a received test packet from the channel; and
determining the bit error rate of the channel based on the received test packet.

- 42. *(previously presented)* The method of claim 41, further including generating an arbitrary ten gigahertz serializer / deserializer (10G SERDES) packet pattern.
- 43. *(previously presented)* The method of claim 42, further including generating the arbitrary 10G SERDES packet pattern using a first pseudo-random number generator.
- 44. *(previously presented)* The method of claim 42, further including programming the arbitrary 10G SERDES packet pattern through a management data input/output interface.
- 45. *(previously presented)* The method of claim 42, further including generating the same arbitrary 10G SERDES packet pattern using a second pseudorandom number generator as the 10G SERDES packet pattern generated by the first pseudo-random number generator.
- 46. *(original)* The method of claim 41, further including counting a number of bytes received during the bit error rate testing.
- 47. *(original)* The method of claim 41, further including counting a number of packets received during the bit error rate testing.

- 48. *(original)* The method of claim 41, further including counting a number of bit errors detected during the bit error rate testing.
- 49. *(original)* The method of claim 41, further including counting a number of bytes with errors detected during the bit error rate testing.
- 50. (original) The method of claim 41, further including counting a number of packets with a byte in error detected during the bit error rate testing.
- 51. (original) The method of claim 41, further including determining a bit error rate of the channel under test.
- 52. *(original)* The method of claim 41, further including counting a number of packets transmitted over the channel.
- 53. (original) The method of claim 41, further including counting a number of number of bytes transmitted over the channel.